

Search Notes

Application/Control No.

10/646,058

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under
Reexamination

ZAPPALA, CHRISTOPHER F.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	149	3/11/2005	PN
/	284		
455	114		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
330	149	3/11/2005	PN
/	284		
455	114		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR